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- 3-State Outputs Drive Bus Lines or Buffer Memory Address Registers
- pnp Inputs Reduce dc Loading
- Package Options Include Plastic Small-Outline (DW) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

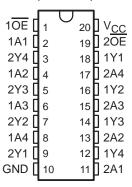
#### description

These octal buffers and line drivers are designed specifically to improve the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters. With the 'ALS240A, 'ALS241C, 'AS240A, and 'AS241A, these devices provide the choice of selected combinations of inverting outputs, symmetrical active-low output-enable ( $\overline{OE}$ ) inputs, and complementary OE and  $\overline{OE}$  inputs.

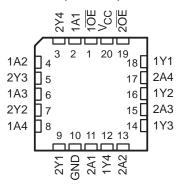
The -1 version of SN74ALS244C is identical to the standard version, except that the recommended maximum  $I_{OL}$  for the -1 version is 48 mA. There is no -1 version of the SN54ALS244C.

The SN54ALS244C and SN54AS244A are characterized for operation over the full military temperature range of -55°C to 125°C. The SN74ALS244C and SN74AS244A are characterized for operation from 0°C to 70°C.

SN54ALS244C, SN54AS244A . . . J PACKAGE SN74ALS244C, SN74AS244A . . . DW OR N PACKAGE (TOP VIEW)



SN54ALS244C, SN54AS244A . . . FK PACKAGE (TOP VIEW)



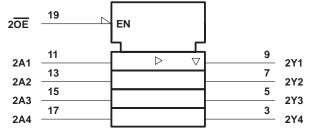
## FUNCTION TABLE (each buffer)

INPU	JTS	OUTPUT
OE	Α	Υ
L	Н	Н
L	L	L
Н	Χ	Z

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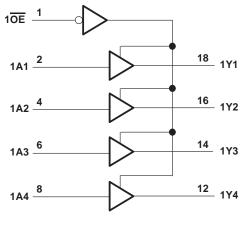
#### logic symbol†

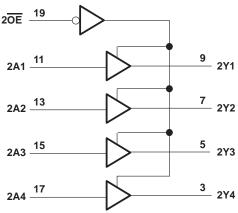
#### 10E ΕN 2 18 1A1 4 16 1A2 1Y2 6 14 1A3 8 12 1A4 1Y4



<sup>&</sup>lt;sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

#### logic diagram (positive logic)





### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage, V <sub>CC</sub>	
Input voltage, V <sub>I</sub>	7 V
Voltage applied to a disabled 3-state output	
Operating free-air temperature range, T <sub>A</sub> : SN54ALS244C	55°C to 125°C
SN74ALS244C	0°C to 70°C
Storage temperature range	−65°C to 150°C

<sup>‡</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

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### recommended operating conditions

			SNS	54ALS24	4C	SN74ALS244C		UNIT		
			MIN	NOM	MAX	MIN	NOM	MAX	UNII	
VCC	Supply voltage		4.5	5	5.5	4.5	5	5.5	V	
٧ <sub>IH</sub>	High-level input voltage		2			2			V	
., .	Laurentina de la companya de la comp			0.8†			0.8	V		
VIL	Low-level input voltage				0.7‡				٧	
loh	High-level output current				-12			-15	mA	
	Love lovel over the company				12			24	A	
IOL	Low-level output current	Low-level output current						48§	mA	
T <sub>A</sub>	Operating free-air temperature		-55		125	0		70	°C	

<sup>†</sup> Applies over temperature range -55°C to 70°C

#### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST	CONDITIONS	SN54ALS244C		SN74ALS244C			UNIT	
PARAMETER	1531 0	CNUITIONS	MIN	TYP¶	MAX	MIN	TYP¶	MAX	UNII
VIK	$V_{CC} = 4.5 \text{ V},$	$I_{I} = -18 \text{ mA}$			-1.5			-1.5	V
	V <sub>CC</sub> = 4.5 V to 5.5 V	$I_{OH} = -0.4 \text{ mA}$	V <sub>CC</sub> -2	2		V <sub>CC</sub> -2	2		
Voн	VCC = 4.5 V to 5.5 V	$I_{OH} = -3 \text{ mA}$	2.4	3.2		2.4	3.2		V
VOH	V <sub>CC</sub> = 4.5 V	$I_{OH} = -12 \text{ mA}$	2						V
	VCC = 4.5 V	I <sub>OH</sub> = -15 mA				2			
		I <sub>OL</sub> = 12 mA		0.25	0.4		0.25	0.4	
V <sub>OL</sub>	V <sub>CC</sub> = 4.5 V	I <sub>OL</sub> = 24 mA					0.35	0.5	V
		I <sub>OL</sub> = 48 mA (-1 version)					0.35	0.5	
lozh	$V_{CC} = 5.5 \text{ V},$	$V_0 = 2.7 \text{ V}$			20			20	μΑ
lozL	$V_{CC} = 5.5 \text{ V},$	$V_0 = 0.4 \text{ V}$			-20			-20	μΑ
lį	$V_{CC} = 5.5 \text{ V},$	V <sub>I</sub> = 7 V			0.1			0.1	mA
l <sub>IH</sub>	$V_{CC} = 5.5 \text{ V},$	V <sub>I</sub> = 2.7 V			20			20	μΑ
I <sub>IL</sub>	$V_{CC} = 5.5 \text{ V},$	V <sub>I</sub> = 0.4 V			-0.1			-0.1	mA
IO#	$V_{CC} = 5.5 \text{ V},$	V <sub>O</sub> = 2.25 V	-20		-112	-30		-112	mA
		Outputs high		9	18		9	17	
Icc	V <sub>CC</sub> = 5.5 V	Outputs low		15	25		15	24	mA
		Outputs disabled		17	29		17	27	

<sup>¶</sup> All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .



<sup>‡</sup> Applies over temperature range 70°C to 125°C

<sup>§</sup> Applies only to the -1 version and only if  $V_{CC}$  is between 4.75 V and 5.25 V

<sup>#</sup> The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, los.

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#### switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	C <sub>l</sub> R1 R2	_ = 50 pF I = 500 £ 2 = 500 £	2,	,	UNIT
			SN54ALS244C		SN74AL		
			MIN	MAX	MIN	MAX	
<sup>t</sup> PLH	Δ.		1	16	2	10	ne
t <sub>PHL</sub>	A	A Y	3	12	3	10	ns
<sup>t</sup> PZH	ŌĒ	v	1	26	3	20	ns
t <sub>PZL</sub>		Y	1	24	3	20	115
<sup>t</sup> PHZ	ŌĒ		2	10	2	10	ns
t <sub>PLZ</sub>	OE	1	1	26	1	13	113

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage, V <sub>CC</sub>	7 V
Input voltage, V <sub>I</sub>	7 V
Voltage applied to a disabled 3-state output	5.5 V
Operating free-air temperature range, T <sub>A</sub> : SN54AS244A	-55°C to 125°C
SN74AS244A	0°C to 70°C
Storage temperature range	-65°C to 150°C

<sup>‡</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### recommended operating conditions

		SN	54AS24	1A	SN74AS244A		UNIT	
		MIN	NOM	MAX	MIN	NOM	MAX	UNII
Vсс	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
V <sub>IL</sub>	Low-level input voltage			0.8			0.8	V
ІОН	High-level output current			-12			-15	mA
loL	Low-level output current			48			64	mA
TA	Operating free-air temperature	-55		125	0		70	°C

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# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEOT 0	ONDITIONS	SN	54AS24	4A	SN	LIMIT		
PARAMETER	IESI C	ONDITIONS	MIN	TYP <sup>†</sup>	MAX	MIN	TYP <sup>†</sup>	MAX	UNIT
VIK	V <sub>CC</sub> = 4.5 V,	I <sub>I</sub> = -18 mA			-1.2			-1.2	V
	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	I <sub>OH</sub> = −2 mA	V <sub>CC</sub> -2	!		V <sub>CC</sub> -2	2		
Vari		$I_{OH} = -3 \text{ mA}$	2.4	3.4		2.4	3.4		V
VOH	V <sub>CC</sub> = 4.5 V	$I_{OH} = -12 \text{ mA}$	2.4						v
		$I_{OH} = -15 \text{ mA}$				2.4			
Va	V00 - 45 V	I <sub>OL</sub> = 48 mA			0.55				V
VOL	V <sub>CC</sub> = 4.5 V	I <sub>OL</sub> = 64 mA						0.55	V
lozh	$V_{CC} = 5.5 \text{ V},$	V <sub>O</sub> = 2.7 V			50			50	μΑ
lozL	$V_{CC} = 5.5 \text{ V},$	V <sub>O</sub> = 0.4 V			-50			-50	μΑ
lį	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 7 V			0.1			0.1	mA
lн	$V_{CC} = 5.5 \text{ V},$	V <sub>I</sub> = 2.7 V			20			20	μΑ
OE	V00 - 5 5 V				-0.5			-0.5	mΛ
I <sub>IL</sub> A	V <sub>CC</sub> = 5.5 V,	$V_{I} = 0.4 V$		-1				-1	mA
IO <sup>‡</sup>	V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 2.25 V	-50		-150	-50		-150	mA
		Outputs high		22	34		22	34	
ICC	V <sub>CC</sub> = 5.5 V	Outputs low		60	90		60	90	mA
		Outputs disabled		34	54		34	54	

### switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	ТО (ОИТРИТ)	V C R R T	UNIT			
			SN54AS244A		SN74AS244A		]
			MIN	MAX	MIN	MAX	]
t <sub>PLH</sub>	А	V	2	9	2	6.2	ns
t <sub>PHL</sub>	A	Y	1	7	1	6.2	115
<sup>t</sup> PZH	ŌĒ	V	1	10	1	9	ns
t <sub>PZL</sub>		Y	2	8	2	7.5	115
<sup>t</sup> PHZ	ŌĒ	V	1	6.5	1	6	ns
<sup>t</sup> PLZ	OE .	'	1	10.5	1	9	115

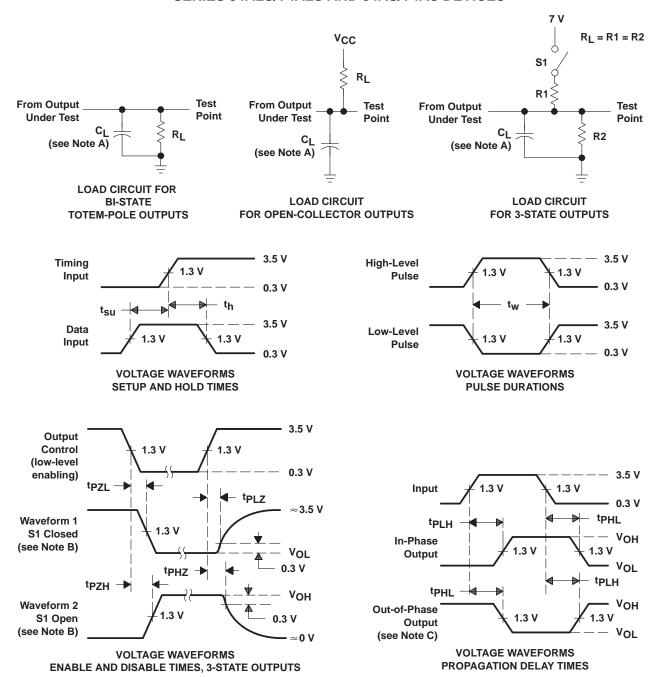
<sup>§</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.



<sup>†</sup> All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C. ‡ The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, I<sub>OS</sub>.

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## PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
- D. All input pulses have the following characteristics: PRR  $\leq$  1 MHz,  $t_r = t_f = 2$  ns, duty cycle = 50%.
- E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms



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